

Notice of References Cited	Application/Control No. 10/814,307	Applicant(s)/Patent Under Reexamination CHA, HYUN ROK	
	Examiner David W. Scheuermann	Art Unit 2834	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,579,004 A	05-1971	Patrick et al.	310/164
	B	US-4,560,226 A	12-1985	Dennis, Alan J.	439/395
	C	US-4,781,618 A	11-1988	Geib et al.	439/392
	D	US-5,001,379 A	03-1991	Katayama, Koji	310/194
	E	US-5,399,097 A	03-1995	Sakai et al.	439/395
	F	US-5,489,223 A	02-1996	Faje et al.	439/748
	G	US-5,952,760 A	09-1999	Miyazawa et al.	310/194
	H	US-2001/0002776 A1	06-2001	Suzuki et al.	310/71
	I	US-6,400,132 B1	06-2002	Koumura, Takashi	324/146
	J	US-6,541,889 B2	04-2003	Moroto et al.	310/216
	K	US-6,861,776 B2	03-2005	Hashimoto, Katsuo	310/71
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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